

M8286/M8287 OCTAL BUS TRANSCEIVER

Military

- Data Bus Buffer Drive for Military M8086, M8088, M80186, M8085A, and M8048AH Processors
- High Output Drive Capability for Driving System Data Bus
- Fully Parallel 8-Bit Transceivers
- **■** 3-State Outputs
- No Output Low Noise When Entering or Leaving High Impedance State
- Military Temperature Range: -55°C to + 125°C (T_C)

The M8286 and M8287 are 8-bit bipolar transceivers with 3-state outputs. The M8287 inverts the input data at its outputs while the M8286 does not. Thus, a wide variety of applications for buffering in microcomputer systems can be met.

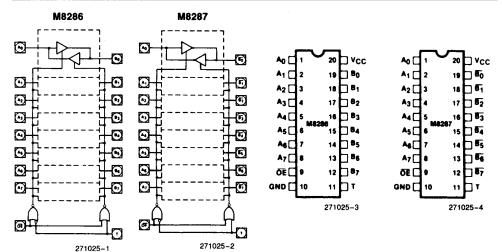
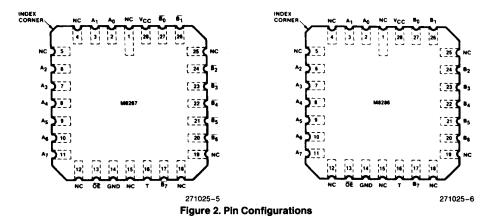


Figure 1. Logic Diagrams



M8286/M8287

Table 1. Pin Description

Symbol	Туре	Name and Function				
Т		TRANSMIT: T is an input control signal used to control the direction of the transceivers. When HIGH, it configures the transceiver's B_0-B_7 as outputs with A_0-A_7 as inputs. T LOW configures A_0-A_7 as the outputs with B_0-B_7 serving as the inputs.				
ŌĒ	ı	OUTPUT ENABLE: OE is an input control signal used to enable the appropriate output driver (as selected by T) onto its respective bus. This signal is active LOW.				
A ₀ -A ₇	1/0	LOCAL BUS DATA PINS: These pins serve to either present data to or accept data from the processor's local bus depending upon the state of the T pin.				
B ₀ -B ₇ (M8286) B ₀ -B ₇ (M8287)	1/0	SYSTEM BUS DATA PINS: These pins serve to either present data to or accept data from the system bus depending upon the state of the T pin.				

FUNCTIONAL DESCRIPTION

The M8286 and M8287 transceivers are 8-bit transceivers with high impedance outputs. With T active HIGH and OE active LOW, data at the A₀-A₇ pins

is driven onto the B₀-B₇ pins. With T inactive LOW and OE active LOW data at the Bo-B7 pins is driven onto the A₀-A₇ pins. No output low glitching will occur whenever the tranceivers are entering or leaving the high impedance state.

ABSOLUTE MAXIMUM RATINGS*

Case Temperature Under Bias(2)55°C to +125°C
Storage Temperature65°C to +150°C
All Output and Supply Voltages $\dots -0.5V$ to $+7V$
All Input Voltages1.0V to +5.5V
Power Dissipation1.0W

*Notice: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

D.C. CHARACTERISTICS $V_{CC} = 5V \pm 5\%$. $T_{C}^{(2)} = -55$ °C to +125°C

Symbol	Parameter Input Clamp Voltage		Min	Max -1	Units V	Test Conditions
Vc						
lcc	Power Supply Current	M8287		130	mA	
		M8286		160	mA	
le	Forward Input Current			-0.2	mA	V _F = 0.45V
I _R	Reverse Input Current			50	μА	V _R = 5.25V
V _{OL}	Output Low Voltage	B Outputs		0.45	٧	I _{OL} = 20 mA
		A Outputs		0.45	٧	I _{OL} = 10 mA
V _{OH}	Output High Voltage	B Outputs	2.4		٧	$I_{OH} = -5 \text{ mA}$
		A Outputs	2.4		٧	I _{OH} = -1 mA
loff loff	Output Off Current Output Off Current			Ē		V _{OFF} = 0.45V V _{OFF} = 5.25V
V _{IL}	Input Low Voltage	A Side		0.8	٧	V _{CC} = 5.0V (Note 1)
		B Side		0.9	٧	V _{CC} = 5.0V (Note 1)
V _{IH}	Input High Voltage		2.0		٧	V _{CC} = 5.0V (Note 1)
CIN	Input Capacitance	OE and T only		12	pF	F = 1 MHz
		All Other Inputs		25	ρF	$V_{BIAS} = 2.5V, V_{CC} = 5V$ $T_{C}^{(2)} = 25^{\circ}C$

NOTE:

- 1. B outputs—I_{OL} = 20 mA, I_{OH} = -5 mA, C_L = 300 pF A outputs—I_{OL} = 10 mA, I_{OH} = -1 mA, C_L = 100 pF 2. Case temperatures are "instant on".

A.C. CHARACTERISTICS $V_{CC} = 5V \pm 5\%$, $T_{C}^{(2)} = -55^{\circ}C$ to $+125^{\circ}C$

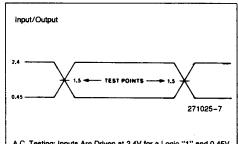
Loading: B Outputs— $I_{OL}=20$ mA, $I_{OH}=-5$ mA, $C_{L}=300$ pF A Outputs— $I_{OL}=10$ mA, $I_{OH}=-1$ mA, $I_{OH}=-1$ mA, $I_{OL}=100$ pF

Symbol	Parameter	Min	Max	Units	Test Conditions
TIVOV	Input to Output Delay Inverting Non-Inverting		25 35	ns ns	(Note 1)
TEHTV	Transmit/Receive Hold Time	TEHOZ		ns	
TTVEL	Transmit/Receive Setup	30		ns	
TEHOZ	Output Disable Time		25	ns	
TELOV	Output Enable Time	10	50	ns	
TOLOH	Output Rise Time		20	ns	From 0.8V to 2.0V
TOHOL	Output Fall Time		12	ns	From 2.0V to 0.8V

NOTES:

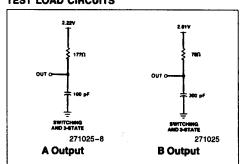
- See waveforms and test load circuit on following pages.
 Case temperatures are "instant on."

A.C. TESTING INPUT, OUTPUT WAVEFORM

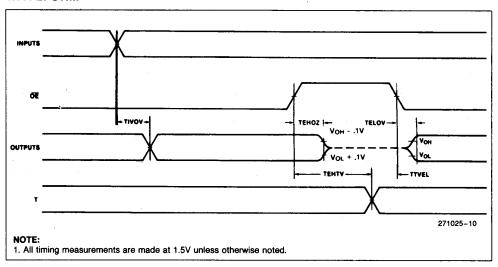


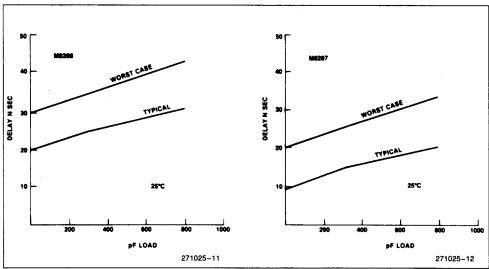
A.C. Testing: Inputs Are Driven at 2.4V for a Logic "1" and 0.45V for a Logic "0." Timing Measurements Are Made at 1.5V for Both a Logic "1" and "0." Input Rise and Fall Times Are Measured from 0.6V to 2.0V and are Driven at 5 ns. ±2 ns.

TEST LOAD CIRCUITS



WAVEFORM





Output Delay vs. Capacitance